DEC 0 2 2010 Sheet 1 of 2

Form PTO-1449 US Dept. of Cor (REV. I/06) PATENT & TRADEMARK C			mmerce OFFICE	ATTY DOCKET NO. 128865				APPLICATION NO. 10/587,268		
INFORMATION DISCLOSURE STATEMENT										
(Use several sheets if necessary)				APPLICANTS Hiroaki TAKAIWA et al.						
				FILING DATE July 26, 2006				GROUP 2882		
U.S. PATENT DOCUMENTS										
Examiner Initials	Cite No.	Document Number	Date		Name					
	1	4,465,368	8/14/1984		Matsuura et al.					
	2	5,493,403	2/20/1996		Nishi					
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FOREIGN PATENT DOCUMENTS								Ι		
Examiner Initials	Cite No.	Document Number	Date		Country			With English Abstract	With English Translation	
	3	JP-A-2004-207696	7/22/200	4	Japan				х	
	4	EP 1 571 699 A1	9/07/200	5	Europe					
	5	WO 04/053958 A1	6/24/200	4	WIPO				х	
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	7	WO 2004/105106 A1	12/02/20	04	WIPO				х	
	8	JP-A-63-73628	4/04/198	8	Japan				х	
	9	JP-A-4-065603	3/02/1992		Japan				х	
	10	JP-A-57-117238	7/21/1982		Japan				х	
	11	JP-A-4-305915	10/28/1992		Japan				х	
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	13	JP-A-10-340846	12/22/1998		Japan				х	
	14	JP-A-11-176727	7/02/199	9	Japan				х	
	15	JP-A-2000-58436	2/25/2000		Japan				х	
	16	JP-A-63-157419	6/30/198	8	Japan				х	
	17	JP-A-58-202448	11/25/19	83	Japan				х	
	18	JP-A-59-19912	2/01/198	4	Japan				х	
	19	JP-A-62-65326	3/24/198	7	Japan				х	
	20	JP-A-5-62877	3/12/1993		Japan			•	х	
	21	JP-A-7-220990	8/18/199	5	Japan				х	
EXAMINER DATE CONSIDERED										
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Date: December 2, 2010

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		U.	S. PATEN						
Examiner Initials	Cite No.	Document Number	Da	Date		Name			
FOREIGN PATENT DOCUMENTS									
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	22	JP-A-8-316125	11/29/19	96	Japan			X	
	23	WO 99/49504	9/30/199	9	WIPO			х	
	24	EP 1 557 721 A2	7/27/200	5	Europe				
	25	JP-A-2000-505958	5/16/200	0	Japan			x	
	26	EP 0 605 103 A1	7/06/199	4	Europe				
	27	EP 1 653 501 A1	5/03/200	6	Еигоре				
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			OTHER D	OCUME	NTS				
Examiner Initials	Cite No.	Including name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.							
	28	November 3, 2010 Notice of Allowance in Application No. 11/651,551.							
	29	August 20, 2010 Supplemental European Search Report in European Application No. 05709451.8.							
	30	May 31, 2005 International Search Report in International Application No. PCT/JP2005/001225, with translation.							
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	32	December 8, 2009 Japanese Office Action in Japanese Application No. 2005-517658, with translation.							
	33	April 6, 2010 Japanese Office Action in Japanese Application No. 2005-517658, with translation.							
EXAMINER						DATE C	ONSIDERED		
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Date: December 2, 2010